

FDS7760A

N-Channel Logic Level PowerTrench® MOSFET

General Description

This N-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

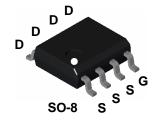
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

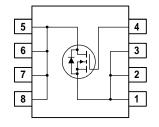
Applications

- DC/DC converter
- Load switch
- Motor drives

Features

- 15 A, 30 V. $R_{DS(ON)} = 5.5 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 8 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$.
- Low gate charge (37nC typical)
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}.
- High power and current handling capability.





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | Parameter | Ratings | Units | |
|-----------------------------------|--|------------|-------------|----|
| V _{DSS} | Drain-Source Voltage | | 30 | V |
| V _{GSS} | Gate-Source Voltage | | ±20 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 15 | А |
| | - Pulsed | | 60 | |
| P _D | Power Dissipation for Single Operation | (Note 1a) | 2.5 | W |
| | | (Note 1b) | 1.2 | |
| | | (Note 1c) | 1 | |
| T _J , T _{STG} | Operating and Storage Junction Temperation | ture Range | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 50 | °C/W |
|------------------|---|-----------|-------------|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1c) | 50 (10 sec) | °C/W |
| R _{eJC} | Thermal Resistance, Junction-to-Case | (Note 1) | 30 | °C/W |

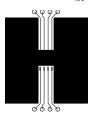
Package Outlines and Ordering Information

| _ | | | | | | | | | |
|---|----------------|----------|-----------|------------|------------|--|--|--|--|
| | Device Marking | Device | Reel Size | Tape Width | Quantity | | | | |
| | FDS7760A | FDS7760A | 13" | 12mm | 2500 units | | | | |

| Symbol | Parameter | Min | Тур | Max | Units | |
|---|---|---|-----|---------------|----------------|----------|
| Off Char | acteristics | 1 | | | ı | I. |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 30 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | 24 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -20 \text{ V } V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 1 | 1.6 | 3 | V |
| $\Delta V_{GS(th)} \over \Delta T_{,J}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | -5 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 13 \text{ A}$ | | 4.5 7 6 | 5.5 10 8 | mΩ |
| I _{D(on)} | On–State Drain Current | $V_{GS} = 10 \text{ V}, \ V_{DS} = 5 \text{ V}$ | 50 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, I_{D} = 15 \text{ A}$ | | 65 | | S |
| Dvnamio | Characteristics | | , | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ | | 3514 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 1123 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 307 | | pF |
| Switchir | g Characteristics (Note 2) | 1 | | | I | I |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 15 \text{ V}, I_{D} = 1 \text{ A},$ | | 13 | 20 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | | 12 | 19 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 78 | 125 | ns |
| t _f | Turn-Off Fall Time | - | | 32 | 51 | ns |
| Q _a | Total Gate Charge | $V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ | | 37 | 55 | nC |
| $\overline{Q_{gs}}$ | Gate-Source Charge | $V_{GS} = 5 \text{ V}$ | | 10 | | nC |
| Q _{gd} | Gate-Drain Charge | | | 12 | | nC |
| Drain_S | ource Diode Characteristics | and Maximum Ratings | 1 | I | I | <u>I</u> |
| l _s | Maximum Continuous Drain–Source | <u>~</u> | | | 2.1 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$ (Note 2) | | 0.7 | 1.2 | V |

Notes:

^{1.} $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 50°/W when mounted on a 1in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in² pad of 2 oz copper



c) 125°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

Typical Characteristics

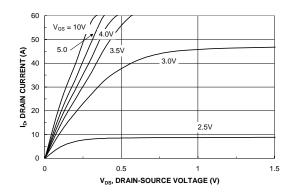


Figure 1. On-Region Characteristics.

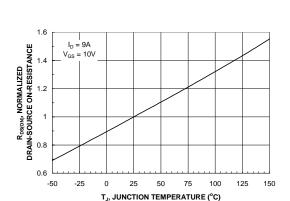


Figure 3. On-Resistance Variation with Temperature.

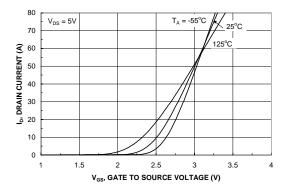


Figure 5. Transfer Characteristics.

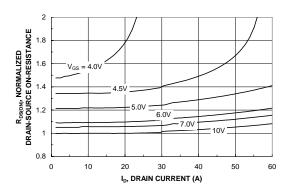


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

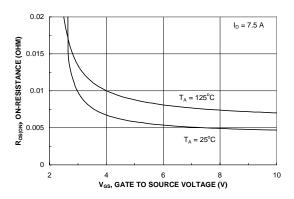


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

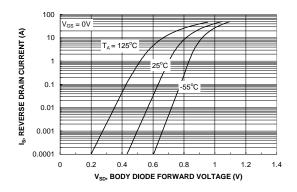
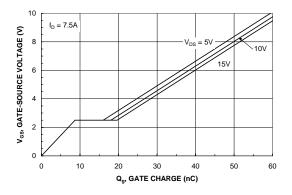


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



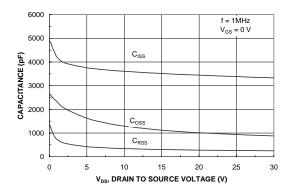
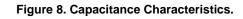
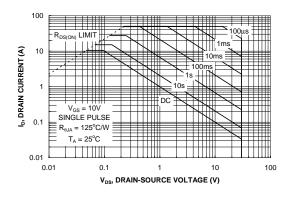


Figure 7. Gate Charge Characteristics.





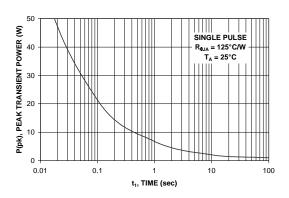


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

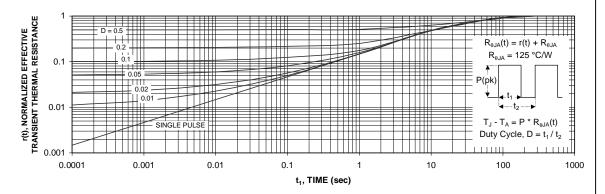
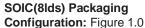


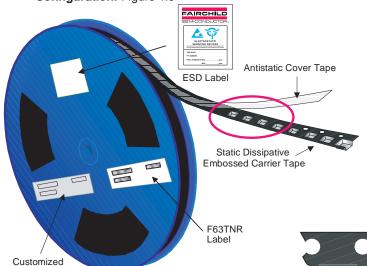
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

SO-8 Tape and Reel Data and Package Dimensions





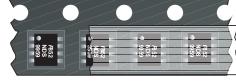


Packaging Description:

Packaging Description:

SOIC-8 parts are shipped in tape. The carrier tape is made from a dissipative (carbon filled) polycarbonate resin. The cover tape is a multilayer film (Heat Activated Adhesive in nature) primarily composed of polyester film, adhesive layer, sealant, and amit-static sprayed agent. These reeled parts in standard option are shipped with 2,500 units per 13° or 300cm diameter reel. The reels are dark blue in color and is made of polystyrene plastic (antistatic coated). Other option comes in 500 units per 7° or 177cm diameter reel. This and some other options are further described in the Packaging Information table.

These full reles are individually barcode labeled and placed inside a standard intermediate box (illustrated in figure 1.0) made of recyclable corrugated brown paper. One box contains two reels maximum. And these boxes are placed inside a barcode labeled shipping box which comes in different sizes depending on the number of parts shipped.





Packaging Option Standard o flow code) L86Z D84Z Rail/Tube TNR Packaging type TNR TNR Qty per Reel/Tube/Bag 2.500 4.000 500 13" Dia 13" Dia 7" Dia 343y64y343 530x130x83 343y64y343 184v187v47 5,000 30,000 8,000 1,000

Box Dimension (mm) Max qty per Box Weight per unit (gm) 0.0774 0.0774 0.0774 0.0774 Weight per Reel (kg) 0.6060 0.9696 0.1182 Note/Comments

SOIC (8lds) Packaging Information

SOIC-8 Unit Orientation

F63TNR Label sample

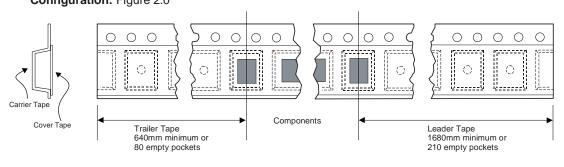
Label

Reel Size



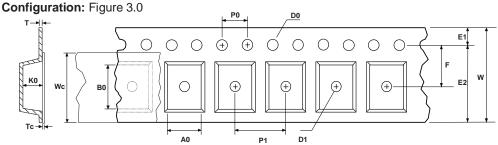
343mm x 342mm x 64mm Standard Intermediate box ESD Label F63TNL F63TN Label

SOIC(8lds) Tape Leader and Trailer Configuration: Figure 2.0





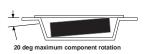
SOIC(8lds) Embossed Carrier Tape



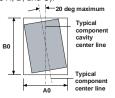


| | Dimensions are in millimeter | | | | | | | | | | | | | |
|----------------------|------------------------------|-----------------|----------------|-----------------|-----------------|-----------------|--------------|-----------------|---------------|---------------|----------------|-----------------------|---------------|-----------------|
| Pkg type | Α0 | В0 | w | D0 | D1 | E1 | E2 | F | P1 | P0 | K0 | т | Wc | Тс |
| SOIC(8lds) (12mm) | 6.50 +/-0.10 | 5.30 +/-0.10 | 12.0 +/-0.3 | 1.55 +/-0.05 | 1.60 +/-0.10 | 1.75 +/-0.10 | 10.25 min | 5.50 +/-0.05 | 8.0 +/-0.1 | 4.0 +/-0.1 | 2.1 +/-0.10 | 0.450 +/- 0.150 | 9.2 +/-0.3 | 0.06 +/-0.02 |

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



Sketch B (Top View)

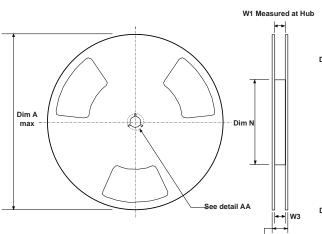
Component Rotation



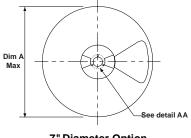
Sketch C (Top View)

Component lateral movement

SOIC(8lds) Reel Configuration: Figure 4.0



13" Diameter Option



7" Diameter Option

B Min

Dim C

Dim D

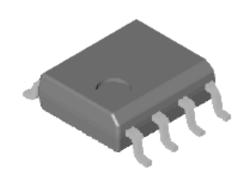
min

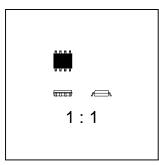
| Dimensions are in inches and millimeters | | | | | | | | | |
|--|----------------|---------------|--------------|-----------------------------------|---------------|-------------|----------------------------------|---------------|------------------------------|
| Tape Size | Reel Option | Dim A | Dim B | Dim C | Dim D | Dim N | Dim W1 | Dim W2 | Dim W3 (LSL-USL) |
| 12mm | 7" Dia | 7.00 177.8 | 0.059 1.5 | 512 +0.020/-0.008 13 +0.5/-0.2 | 0.795 20.2 | 2.165 55 | 0.488 +0.078/-0.000 12.4 +2/0 | 0.724 18.4 | 0.469 - 0.606 11.9 - 15.4 |
| 12mm | 13" Dia | 13.00 330 | 0.059 1.5 | 512 +0.020/-0.008 13 +0.5/-0.2 | 0.795 20.2 | 7.00 178 | 0.488 +0.078/-0.000 12.4 +2/0 | 0.724 18.4 | 0.469 - 0.606 11.9 - 15.4 |

W2 max Measured at Hub

SO-8 Tape and Reel Data and Package Dimensions, continued

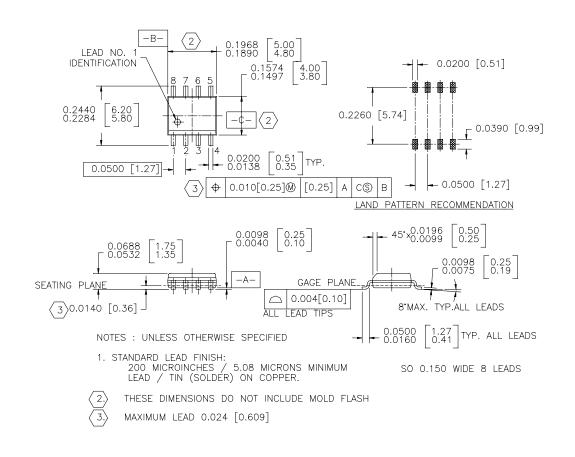
SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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